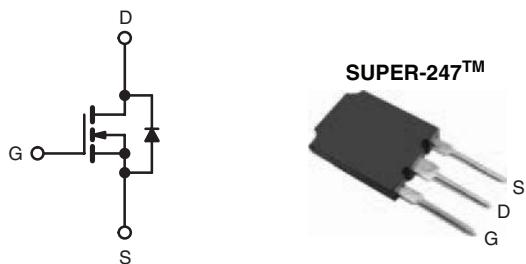


## Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	500
R <sub>D(on)</sub> (Ω)	V <sub>GS</sub> = 10 V      0.125
Q <sub>g</sub> (Max.) (nC)	230
Q <sub>gs</sub> (nC)	65
Q <sub>gd</sub> (nC)	110
Configuration	Single



N-Channel MOSFET


**RoHS\***  
COMPLIANT

### FEATURES

- Super Fast Body Diode Eliminates the Need for External Diodes in ZVS Applications
- Lower Gate Charge Results in Simpler Drive Requirements
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Lead (Pb)-free Available

### APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION	
Package	SUPER-247™
Lead (Pb)-free	IRFPS35N50LPbF SiHFPS35N50L-E3
SnPb	IRFPS35N50L SiHFPS35N50L

ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V <sub>DS</sub>	500	
Gate-Source Voltage		V <sub>GS</sub>	± 30	V
Continuous Drain Current	V <sub>GS</sub> at 10 V	I <sub>D</sub>	34	
	T <sub>C</sub> = 25 °C		22	A
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	140	
Linear Derating Factor			3.6	W/°C
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	560	mJ
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	34	A
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	45	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	450	W
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	15	V/ns
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting T<sub>J</sub> = 25 °C, L = 0.97 mH, R<sub>G</sub> = 25 Ω, I<sub>AS</sub> = 34 A (see fig. 12).
- I<sub>SD</sub> ≤ 34 A, dI/dt ≤ 765 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

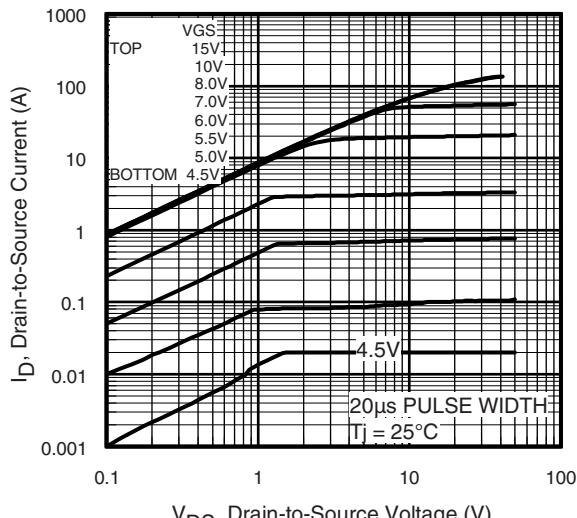
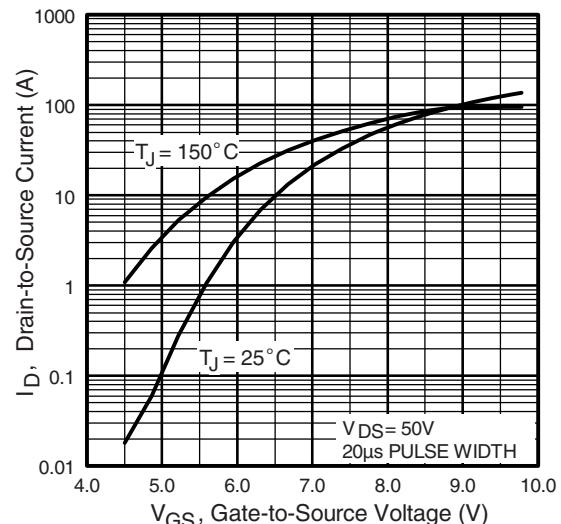
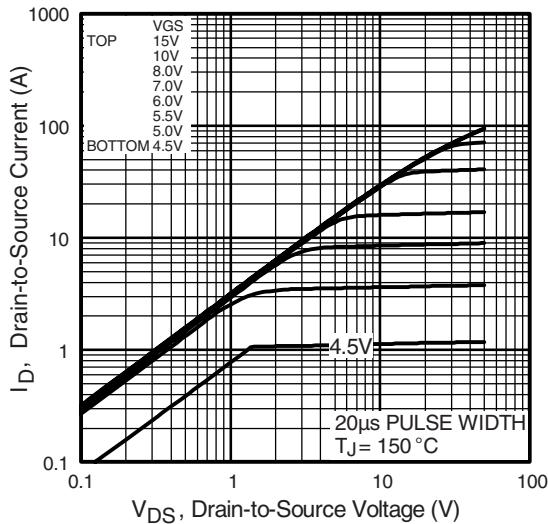
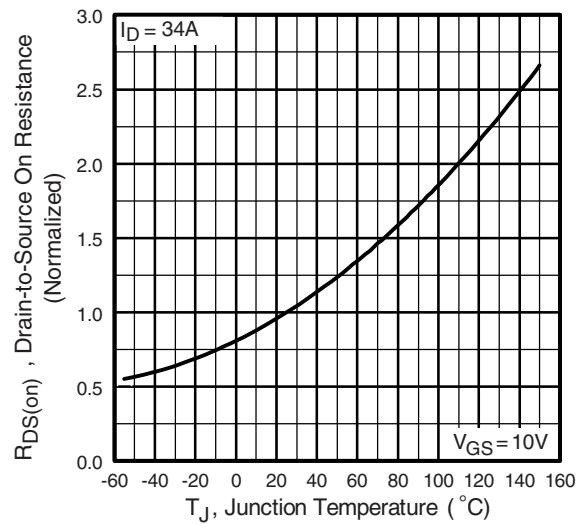
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	40	$^{\circ}\text{C}/\text{W}$
Case-to-Sink, Flat, Greased Surface	$R_{thCS}$	0.24	-	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.28	

**Note**a.  $R_{th}$  is measured at  $T_J$  approximately 90  $^{\circ}\text{C}$ .**SPECIFICATIONS**  $T_J = 25 \text{ } ^{\circ}\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	500	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 $^{\circ}\text{C}$ , $I_D = 1 \text{ mA}$	-	0.12	-	$\text{V}/^{\circ}\text{C}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	3.0	-	5.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30 \text{ V}$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 500 \text{ V}$ , $V_{GS} = 0 \text{ V}$	-	-	50	$\mu\text{A}$
		$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125 \text{ } ^{\circ}\text{C}$	-	-	2.0	mA
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 20 \text{ A}^b$	-	0.125	0.145
Forward Transconductance	$g_{fs}$	$V_{DS} = 50 \text{ V}$	$I_D = 20 \text{ A}^b$	18	-	-
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5	-	5580	-	pF
Output Capacitance	$C_{oss}$		-	590	-	
Reverse Transfer Capacitance	$C_{rss}$		-	58	-	
Output Capacitance	$C_{oss}$	$V_{GS} = 0 \text{ V}$	$V_{DS} = 1.0 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	7290	pF
Effective Output Capacitance	$C_{oss eff.}$		$V_{DS} = 400 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	160	
Effective Output Capacitance (Energy Related)	$C_{oss eff. (ER)}$		$V_{DS} = 0 \text{ V to } 400 \text{ V}^c$	-	320	
Total Gate Charge	$Q_g$		-	220	-	
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10 \text{ V}$	$I_D = 34 \text{ A}$ , $V_{DS} = 400 \text{ V}$ , see fig. 7 and 13 <sup>b</sup>	-	-	nC
Gate-Drain Charge	$Q_{gd}$		-	-	230	
Internal Gate Resistance	$R_G$		$f = 1 \text{ MHz}$ , open drain	-	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 250 \text{ V}$ , $I_D = 34 \text{ A}$ , $R_G = 1.2 \Omega$ , see fig. 10 <sup>b</sup>	-	-	24	ns
Rise Time	$t_r$		-	-	100	
Turn-Off Delay Time	$t_{d(off)}$		-	-	42	
Fall Time	$t_f$		-	-	42	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode	-	-	34	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$	-	-	140		
Body Diode Voltage	$V_{SD}$	$T_J = 25 \text{ } ^{\circ}\text{C}$ , $I_S = 34 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$	-	-	1.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25 \text{ } ^{\circ}\text{C}$ , $I_F = 34 \text{ A}$	-	170	250	ns
		$T_J = 125 \text{ } ^{\circ}\text{C}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$	-	220	330	
Body Diode Reverse Recovery Charge	$Q_{rr}$	$T_J = 25 \text{ } ^{\circ}\text{C}$ , $I_S = 34 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$	-	670	1010	$\mu\text{C}$
		$T_J = 125 \text{ } ^{\circ}\text{C}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$	-	1500	2200	
Reverse Recovery Current	$I_{RRM}$	$T_J = 25 \text{ } ^{\circ}\text{C}$	-	8.5	-	A
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )	-	-	-	

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 400 \mu\text{s}$ ; duty cycle  $\leq 2 \%$ .  
c.  $C_{oss eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .  
 $C_{oss eff. (ER)}$  is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Fig. 1 - Typical Output Characteristics**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRFPS35N50L, SiHFPS35N50L

Vishay Siliconix

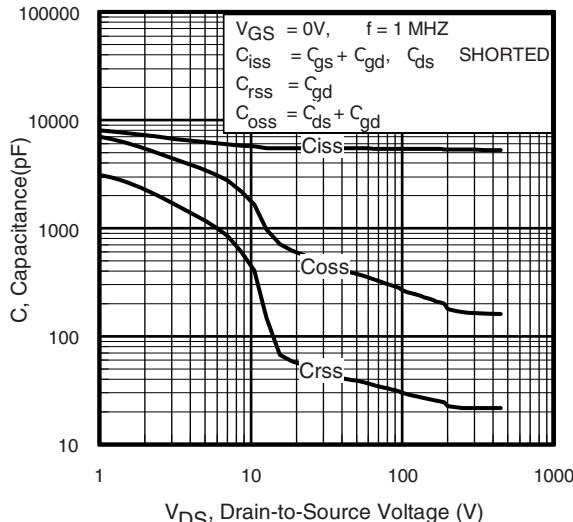


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

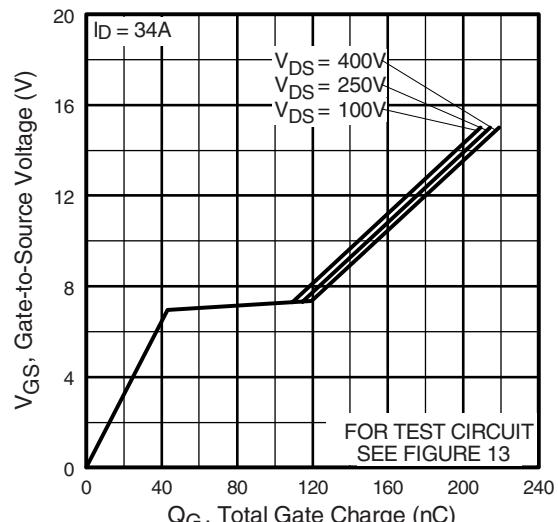


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

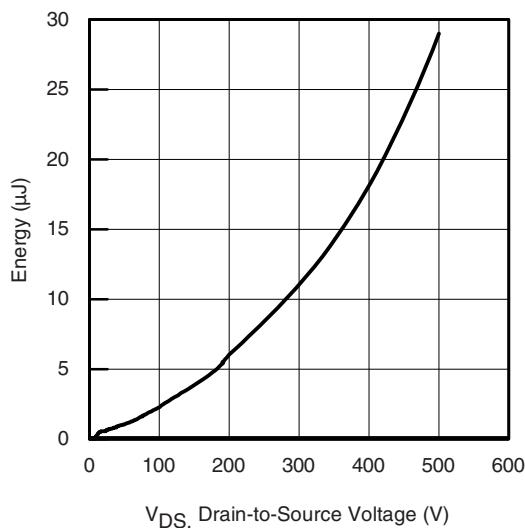


Fig. 6 - Typical Output Capacitance Stored Energy vs.  $V_{DS}$

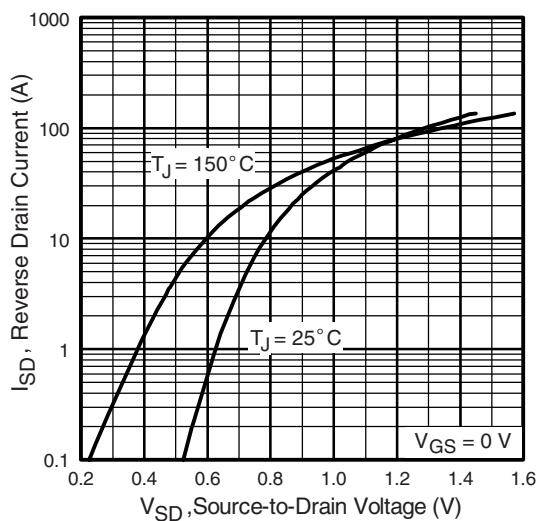


Fig. 8 - Typical Source Drain Diode Forward Voltage

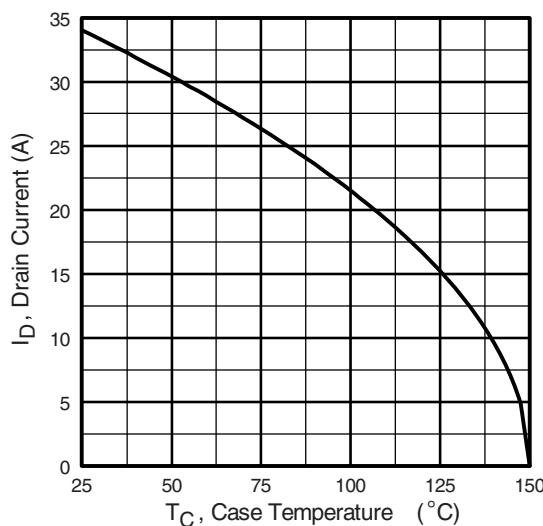


Fig. 9 - Maximum Drain Current vs. Case Temperature

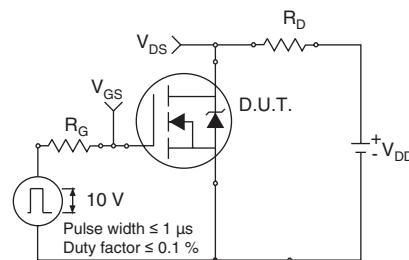


Fig. 10a - Switching Time Test Circuit

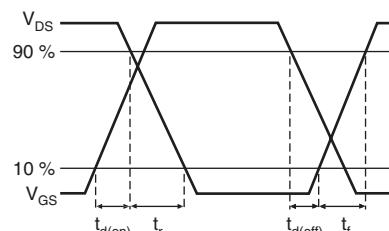


Fig. 10b - Switching Time Waveforms

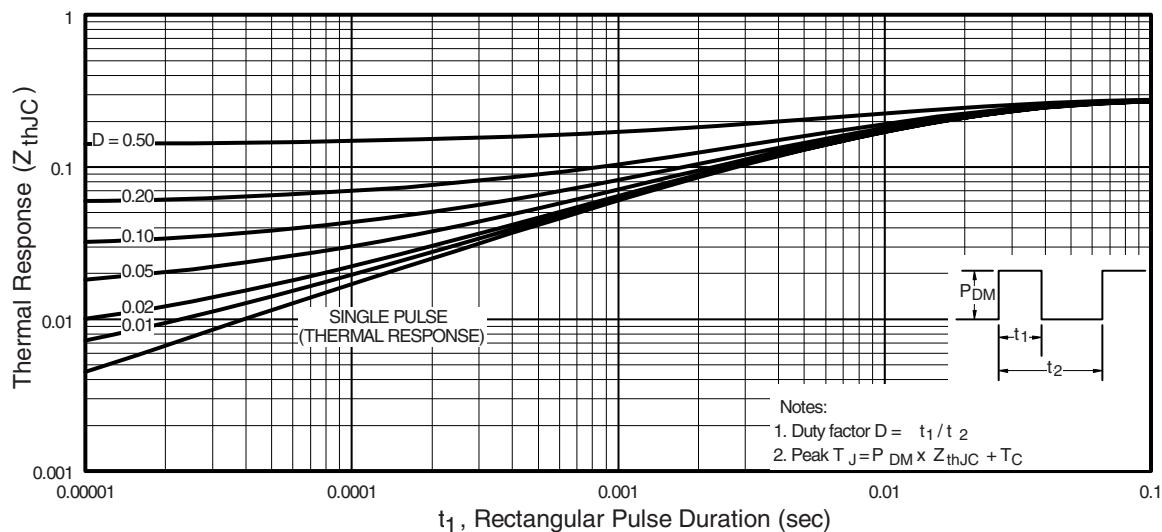


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

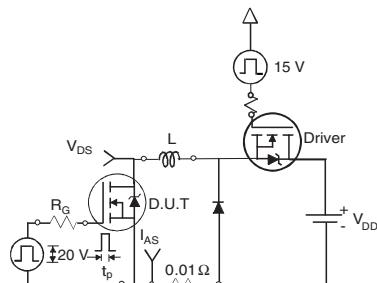


Fig. 12a - Unclamped Inductive Test Circuit

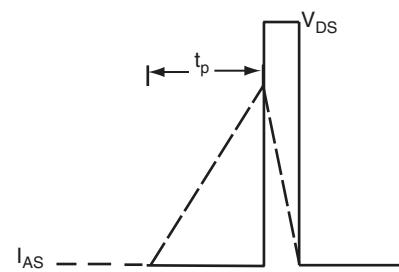


Fig. 12b - Unclamped Inductive Waveforms

# IRFPS35N50L, SiHFPS35N50L

Vishay Siliconix

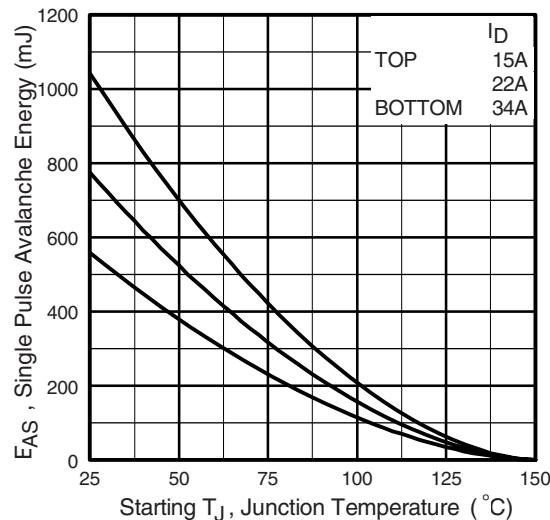


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

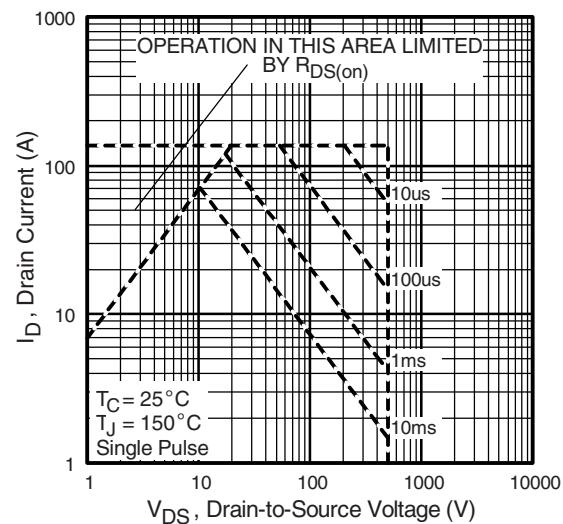


Fig. 12d - Maximum Safe Operating Area

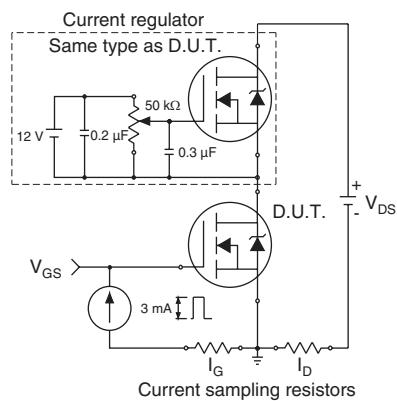


Fig. 13a - Gate Charge Test Circuit

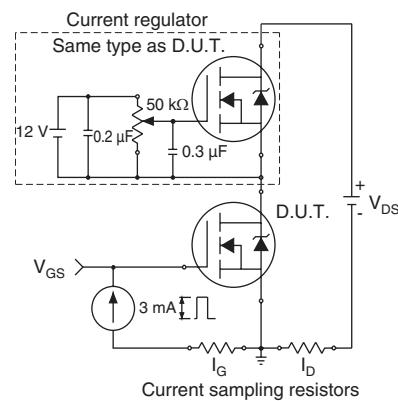
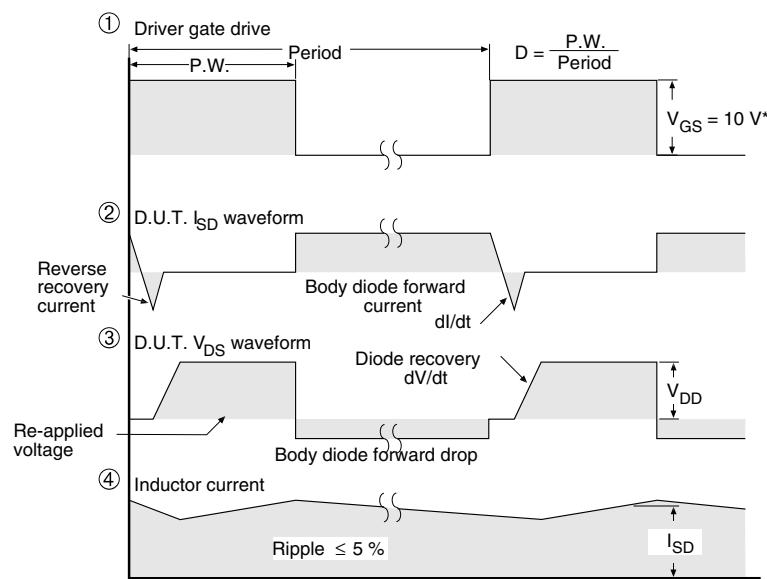
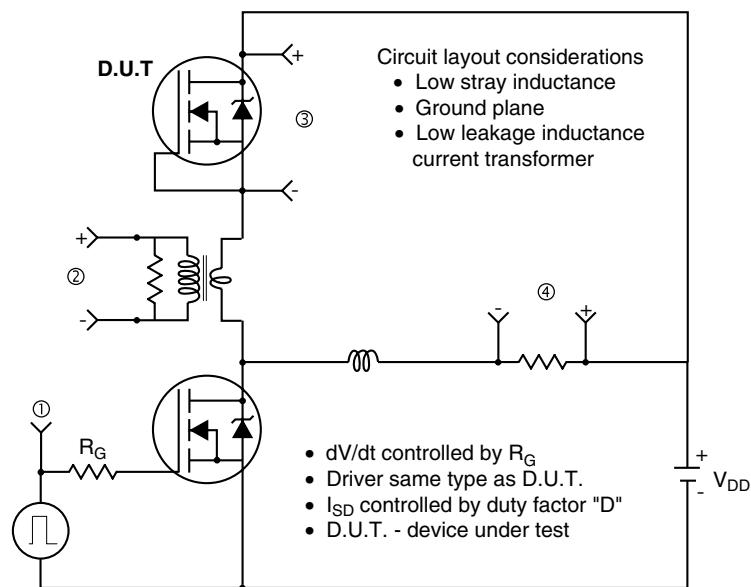


Fig. 13b - Basic Gate Charge Waveform

### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = 5 \text{ V}$  for logic level devices

**Fig. 14 - For N-Channel**

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